SEFELEC 56-H

The EATON Dielectric Strength Tester



SEFELEC 56-H features and benefits:

Dielectric withstand at 5kVAC 50VA and 6kVDC

Detection modes with Min/Max current thresholds or flashover detection (ΔI)

Burning function without current detection

Programmables test ramps

Rise, dwell, fall Multi-ramp mode, up to 7 steps

7" TFT Multi touchscreen 16 million colors for programming, tests and results display

ARM-Dual core control & Nand 3D technologies inside for more accuracy, stability and repeatability

DSPs speeds up measurements and production tests

Large internal memory for configurations and test results storage

IEC 61010-2-034 full compliance, specific safety standard for insulation and dielectric strength meters

The **SEFELEC 56-H** is a new generation EATON dielectric strength tester (hipot tester) based and controlled by ARM-Dual Core and DSP technologies providing the best stability and repeatability.

The high accuracy and measurement speed are suitable for quality control or incoming inspection departments.

The sequence mode makes the **SEFELEC 56-H** easier to use and integrate in a control or a test-bench.

The new SEFELEC Series HMI, with its 7" dual-touch TFT screen, offers simple and intuitive operations.

- Native Ethernet / RS232 / USB / PLC / 0-10 V / CAN IEEE488-2 interface in option
- IEEE488-2 Interface as on option
- CAN Bus CAN to drive extension modules (Scanners)
- SIL2 double safety loop
- Automatic measurement range selection
- Sequence mode to combine several successive tests





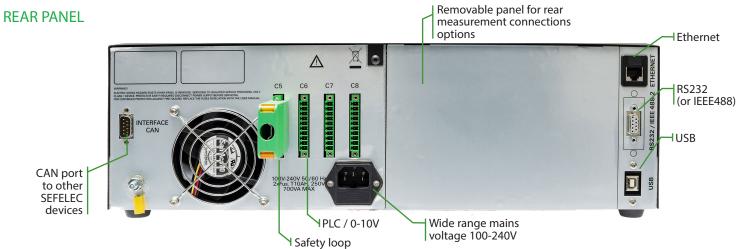




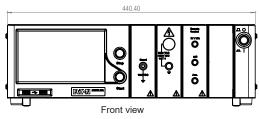


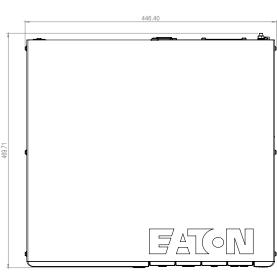
SEFELEC 56-H: Dielectric Withstand Tester - General Overview



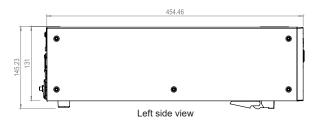


DIMENSIONAL DIAGRAMS



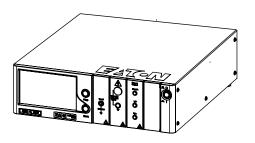


Top view



Rack-Mount operation requires SEFA-KR adaptor.

SEFO-5XREAR option provides measurement connectors on the back plane.



SEFELEC 56-H: Touchscreen Overview





Passed test



Failed test



Permanent measurement mode



Manual mode



Multi-steps mode



Measurement mode selection



Communication configuration

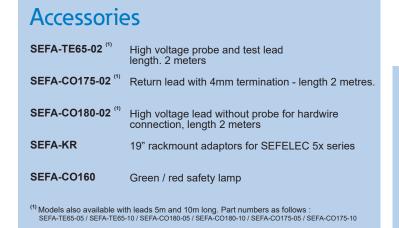


Measurement parameters configuration



Sequence mode

SEFELEC 56-H: Accessories & Options







SEFO-IEEE488

Options	
SEFO-5XRC	Remote controls connection module
SEFO-5X2TO	2TΩ insulation measurement range
SEEO IEEE400	IEEE499 2 communication

SEFO-5XREAR Rear panel measurement connection
SEFO-5X3MA 3mA max. output current limitation

(Hipot function)

Company Company Company				
General Specifications	100 0101/10 111111			
Mains voltage	100-240 VAC ±10 % 50 to 60 Hz / single phase			
Mains protection	Temporized double fuse T10AH 250V			
Input power	700 VA max.			
Temperature range	Storage:-10°C to +60°C			
Altitude	Up to 2 000 m			
Relative humidity	80 % max. @ 31°C			
Dimensions & weight	Height Width	Depth	Weight	
	131 mm 440 mm	455 mmm	approx. 15 kg	
Output Withstand Voltage				
Signal	50 Hz or 60 Hz sinus			
Range	100 V to 5 000 V AC 100 V to 6 000 V DC			
DC polarity	Positive pole connected to the bond			
Dynamic stability	for $\Delta V_{mains} = \pm 10 \%$ measurement voltage variation $< \pm 1\%$			
DC voltage ripple	< 1% with a current <100 μA			
Generetor accuracy	± (2% + 5 V) witha current <100 μA over full range in AC or DC			
Max D.U.T. capacitance	< 1 μF (discharge time < 10 s)			
Discharge resistor	1,5 MΩ in DC - D.U.T. and internal capacitor discharge			
Voltage Measurement				
Through a kilovoltmeter directly connected to output				
Accuracy	± (1,5% + 5 V)			
Resolution	600 digits			
Short-Circuit Current				
at 5 000V AC	< 20 mA			
at 6 000V DC	< 20 mA			
Default Detection	12011111			
	and audible signal. Default vol	tage and low fault cu	want stayed in the display and memory	
Fault indication with a message on the LCD display, LEDs a Flashover Current Mode ΔI : The ΔI detection (delta I) mak appears rapidly when there is a default : $I' = I + I_{default}$				
Ajustement range	from 1 mA ± 10 % to 10 mA	± 10 % by steps of 1 r	mA	
Pulse width	>10 µs ± 20%	,		
Current Threshold Made L. The device continuously m	<u> </u>	ng through the DIIT	and compares it throsholds sattings. 2 cases	
Current Threshold Mode I _{MAX} : The device continuously m			the threshold, the test is declared FAIL: DIS-	
High limit > 0,000 mA & Low limit set at 0,000mA	JUNCTION. If the current is	ower than the High Li	mit, the test is declared PASS	
Low limit > 0,000 mA et High limit > Low limit	The measured current is within the range defined by the thresholds, the test result is PASS, outside the test is declared FAIL.			
		FAIL.	•	
Current Threshold Mode I_{MIN} : It is possible to specify a m 9,999 mA. I_{MIN} mode use ensures that the D.U.T. is correctly	ninimum value of current flow y connected to the tester.	FAIL. ing through the D.U.T.	. The I _{MIN} value can be set from 0,000 mA to	
	ninimum value of current flow y connected to the tester.	FAIL. ing through the D.U.T.	. The I _{MIN} value can be set from 0,000 mA to	
9,999 mA. I _{MIN} mode use ensures that the D.U.T. is correctl	ninimum value of current flow y connected to the tester.	FAIL. ing through the D.U.T.	. The I _{MIN} value can be set from 0,000 mA to	
9,999 mA. I_{MIN} mode use ensures that the D.U.T. is correctl Without Detection Mode: There is no current control in thi	ininimum value of current flow y connected to the tester. s mode (burning mode). Gene	FAIL. ing through the D.U.T.	. The I _{MIN} value can be set from 0,000 mA to	
9,999 mA. I _{MIN} mode use ensures that the D.U.T. is correctl Without Detection Mode : There is no current control in thi Permanent Current Measurement	ininimum value of current flow y connected to the tester. s mode (burning mode). Gene	FAIL. ing through the D.U.T.	. The I _{MIN} value can be set from 0,000 mA to	
9,999 mA. I _{MIN} mode use ensures that the D.U.T. is correctl Without Detection Mode: There is no current control in this Permanent Current Measurement The current measurement is done by a shunt installed in the current measurement is done by a shunt installed in the current measurement.	ninimum value of current flow y connected to the tester. s mode (burning mode). Gene he test circuit.	FAIL. ing through the D.U.T.	. The I _{MIN} value can be set from 0,000 mA to	
9,999 mA. I _{MIN} mode use ensures that the D.U.T. is correctl Without Detection Mode: There is no current control in this Permanent Current Measurement The current measurement is done by a shunt installed in the Resolution	ninimum value of current flow y connected to the tester. s mode (burning mode). Gene he test circuit.	FAIL. ing through the D.U.T. rator is protected aga	. The I _{MIN} value can be set from 0,000 mA to	
9,999 mA. I _{MIN} mode use ensures that the D.U.T. is correctl Without Detection Mode: There is no current control in this Permanent Current Measurement The current measurement is done by a shunt installed in the Resolution	ninimum value of current flow y connected to the tester. s mode (burning mode). Gene he test circuit. 9 999 points 0,001 mA to 9,999 mA	FAIL. ing through the D.U.T. rator is protected aga $\pm (2 \% + 3 \mu A)$. The I _{MIN} value can be set from 0,000 mA to	
9,999 mA. I _{MIN} mode use ensures that the D.U.T. is correctl Without Detection Mode: There is no current control in thi Permanent Current Measurement The current measurement is done by a shunt installed in t Resolution Total current accuracy (in AC and DC)	ninimum value of current flow y connected to the tester. s mode (burning mode). Gene he test circuit. 9 999 points 0,001 mA to 9,999 mA	FAIL. ing through the D.U.T. rator is protected aga $\pm (2 \% + 3 \mu A)$. The I _{MIN} value can be set from 0,000 mA to	
9,999 mA. I_{MIN} mode use ensures that the D.U.T. is correctl Without Detection Mode: There is no current control in this Permanent Current Measurement The current measurement is done by a shunt installed in the Resolution Total current accuracy (in AC and DC) Accuracy in DC current for a load > 1 M Ω	he test circuit. 9 999 points 0,001 mA to 20,00 mA	FAIL. ing through the D.U.T. rator is protected aga $\pm (2 \% + 3 \mu A)$ $\pm (2 \% + 0.05 \mu A)$ active. The output vo	. The I _{MIN} value can be set from 0,000 mA to inst overheat.	
9,999 mA. I_{MIN} mode use ensures that the D.U.T. is correctl Without Detection Mode: There is no current control in this Permanent Current Measurement The current measurement is done by a shunt installed in the Resolution Total current accuracy (in AC and DC) Accuracy in DC current for a load > 1 M Ω Ramp mode	ininimum value of current flowly connected to the tester. s mode (burning mode). Genethe test circuit. 9 999 points 0,001 mA to 9,999 mA 10,00 mA to 20,00 mA The rise time duration set is a fault or if pressing the red	FAIL. ing through the D.U.T. rator is protected aga $\pm (2\% + 3 \mu A)$ $\pm (2\% + 0.05 mA)$ active. The output volutton on the front protection of the front protection of the protection of th	The I _{MIN} value can be set from 0,000 mA to inst overheat. Soltage rises to the setpoint. Test stops if there is anel. d down arrows on the touch-screen. Test stops	
9,999 mA. I_{MIN} mode use ensures that the D.U.T. is correctl Without Detection Mode: There is no current control in this Permanent Current Measurement The current measurement is done by a shunt installed in the Resolution Total current accuracy (in AC and DC) Accuracy in DC current for a load > 1 M Ω Ramp mode PERMANENT mode	he test circuit. 9 999 points 0,001 mA to 9,999 mA 10,00 mA to 20,00 mA The rise time duration set is a fault or if pressing the red if there is a fault or if pressir	FAIL. ing through the D.U.T. rator is protected aga $\pm (2\% + 3 \mu A)$ $\pm (2\% + 0.05 mA)$ active. The output volutton on the front protection on the front protection on the red button on the red button on the red button on the red raise up to set volution.	The I _{MIN} value can be set from 0,000 mA to inst overheat. Soltage rises to the setpoint. Test stops if there is anel. d down arrows on the touch-screen. Test stops	
9,999 mA. I_{MIN} mode use ensures that the D.U.T. is correct! Without Detection Mode: There is no current control in this Permanent Current Measurement The current measurement is done by a shunt installed in the Resolution Total current accuracy (in AC and DC) Accuracy in DC current for a load > 1 M Ω Ramp mode PERMANENT mode MANUAL mode	he test circuit. 9 999 points 0,001 mA to 20,00 mA The rise time duration set is a fault or if pressing the red No rise time is set. Manual cif there is a fault or if pressir Test runs in 3 sequences: lir	FAIL. ing through the D.U.T. rator is protected aga $\pm (2\% + 3 \mu A)$ $\pm (2\% + 0.05 mA)$ active. The output volutton on the front prontrol pressing up an ing the red button on the active are descent to 0V (Fall)	The I _{MIN} value can be set from 0,000 mA to inst overheat. Stage rises to the setpoint. Test stops if there is anel. d down arrows on the touch-screen. Test stops he front panel.	

Eaton - Sefelec sas 19 rue des Campanules F-77185 Lognes Headquarters +33 (0)1 64 11 83 42 +33 (0)1 64 11 83 48

Eaton - Sefelec GmbH Karl- Bold- Str. 40 D-77855 Achern Zentrale +49 (0) 7841 640 77 0 Fax +49 (0) 7841 640 77 29

Please learn more about SEFELEC 5x series on: Sefelec.com

Eaton and Intelligent Power are registered All other trademarks are property of their

respective owners.

Follow us on social media to get the latest product and support information.













Powering Business Worldwide